

# Search Notes



Application/Control No.

10/524,238

Examiner

DiLinh Nguyen

Applicant(s)/Patent under Reexamination

MIURA ET AL.

Art Unit

2814

## SEARCHED

Class	Subclass	Date	Examiner
257	784	11/1/06	DLN
	786		
	678		
	685		
	723		
	724		
	730		
	731		
257	733	11/1/06	DLN

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
DRS Search	11/1/06	DLN